

<b>Notice of References Cited</b>	Application/Control No. 10/062,201	Applicant(s)/Patent Under Reexamination FUX ET AL.	
	Examiner Joseph S. Del Sole	Art Unit 1722	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,450,796	09-2002	Groff et al.	425/192R
	B	US-4,288,463	09-1981	Groff et al.	426/500
	C	US-3,940,226	02-1976	Verhoeven, Albert F. L.	425/375
	D	US-5,620,713	04-1997	Rasmussen, Glenn O.	425/131.1
	E	US-4,906,171	03-1990	Miller, William H.	425/131.1
	F	US-3,752,632	08-1973	Heesen, Theodorus Jacobus	425/331
	G	US-5,637,341	06-1997	Rivlin, Ram	426/496
	H	US-5,834,040	11-1998	Israel et al.	425/381
	I	US-6,428,830	08-2002	Matthews et al.	426/92
	J	US-3,694,292	09-1972	Schippers et al.	156/501
	K	US-4,208,178	06-1980	Przytulla, Dietmar	425/467
	L	US-2002/0084281	07-2002	Horna et al.	222/1
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0 434 983 A1	07-1991	EPO	Farnsworth et al.	---
	O	EP 0 287 209 A2	10-1988	EPO	Hayashi et al.	---
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.